

October 1987 Revised January 1999

CD4043BC • CD4044BC Quad 3-STATE NOR R/S Latches • Quad 3-STATE NAND R/S Latches

General Description

The CD4043BC are quad cross-couple 3-STATE CMOS NOR latches, and the CD4044BC are quad cross-couple 3-STATE CMOS NAND latches. Each latch has a separate Q output and individual SET and RESET inputs. There is a common 3-STATE ENABLE input for all four latches. A logic "1" on the ENABLE input connects the latch states to the Q outputs. A logic "0" on the ENABLE input disconnects the latch states from the Q outputs resulting in an open circuit condition on the Q output. The 3-STATE feature allows common bussing of the outputs.

Features

■ Wide supply voltage range: 3V to 15V

■ Low power: 100 nW (typ.)

■ High noise immunity: 0.45 V_{DD} (typ.)

- Separate SET and RESET inputs for each latch
- NOR and NAND configuration
- 3-STATE output with common output enable

Applications

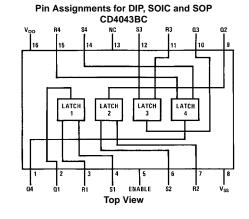
- Multiple bus storage
- · Strobed register
- Four bits of independent storage with output enable
- · General digital logic

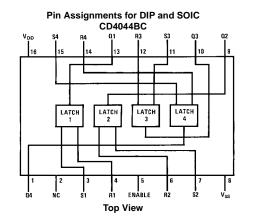
Ordering Code:

Order Number	Package Number	Package Description
CD4043BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
CD4043BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
CD4044BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
CD4044BCSJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
CD4044BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

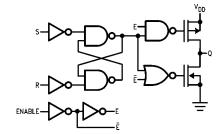
Connection Diagrams



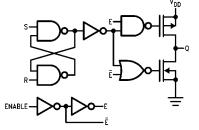


Block Diagrams

CD4043BC



CD4044BC



Truth Tables

CD4043BC

S	R	E	Q
Х	Х	0	OC NC
0	0	1	NC
1	0	1	1
0	1	1	0
1	1	1	Δ

CD4044BC

S	R	E	Q
Х	Χ	0	OC NC
1	1	1	NC
0	1	1	1
1	0	1	0
0	0	1	$\Delta\Delta$

OC = 3-STATE NC = No change X = Don't care $\Delta = Dominated by S = 1 input$ $\Delta\Delta = Dominated by R = 0 input$

Absolute Maximum Ratings(Note 1)

(Note 2)

 $\label{eq:Supply Voltage (V_DD)} Supply \mbox{ Voltage (V_DD)} \qquad -0.5 \mbox{V to } +18 \mbox{V} \\ \mbox{Input Voltage (V_IN)} \qquad -0.5 \mbox{V to } \mbox{V}_{DD} +0.5 \mbox{V} \\ \mbox{ } \mbox{}$

Storage Temperature Range (Ts) -65°C to +150°C

Power Dissipation (P_D)

 Dual-In-Line
 700 mW

 Small Outline
 500 mW

Lead Temperature (T_L)

(Soldering, 10 seconds) 260°C

Recommended Operating Conditions

(Note 2)

 $\begin{array}{ll} \mbox{Supply Voltage (V_{DD})} & 3.0 \mbox{V to 15V} \\ \mbox{Input Voltage (V_{IN})} & 0 \mbox{ to V}_{DD} \mbox{ V} \\ \end{array}$

Operating Temperature Range (T_A)

Note 1: "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed; they are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and "Electrical Characteristics" provide conditions for actual device operation.

Note 2: $V_{SS} = 0V$ unless otherwise specified.

DC Electrical Characteristics (Note 2)

Symbol	Parameter	Conditions	-40	-40°C		+25°C			+85°C	
		Conditions	Min	Max	Min	Тур	Max	Min	Max	Units
I _{DD}	Quiescent	$V_{DD} = 5V$, $V_{IN} = V_{DD}$ or V_{SS}		20		0.01	20		150	μΑ
	Device Current	$V_{DD} = 10V$, $V_{IN} = V_{DD}$ or V_{SS}		40		0.01	40		300	μΑ
		$V_{DD} = 15V$, $V_{IN} = V_{DD}$ or V_{SS}		80		0.02	80		600	μΑ
V _{OL}	LOW Level	$ I_{O} \le 1 \mu A, V_{IL} = 0V, V_{IH} = V_{DD}$								
	Output Voltage	$V_{DD} = 5.0V$		0.05		0	0.05		0.05	V
		$V_{DD} = 10V$		0.05		0	0.05		0.05	V
		$V_{DD} = 15V$		0.05		0	0.05		0.05	V
V _{OH}	HIGH Level	$ I_{O} \le 1 \mu A, V_{IL} = 0V, V_{IH} = V_{DD}$								
	Output Voltage	V _{DD} = 5.0V	4.95		4.95	5.0		4.95		V
		$V_{DD} = 10V$	9.95		9.95	10		9.95		V
		$V_{DD} = 15V$	14.95		14.95	15		14.95		V
V _{IL}	LOW Level	I _O ≤ 1 μA								
	Input Voltage	$V_{DD} = 5.0V$, $V_{O} = 0.5V$ or 4.5V		1.5		2.25	1.5		1.5	V
		$V_{DD} = 10V, V_{O} = 1.0V \text{ or } 9.0V$		3.0		4.5	3.0		3.0	V
		$V_{DD} = 15V$, $V_{O} = 1.5V$ or $13.5V$		4.0		6.75	4.0		4.0	V
V _{IH}	HIGH Level	I _O ≤ 1 μA								
	Input Voltage	$V_{DD} = 5.0V$, $V_{O} = 0.5V$ or 4.5V	3.5		3.5			3.5		V
		$V_{DD} = 5.0V$, $V_{O} = 1.0V$ or $9.0V$	7.0		7.0			7.0		V
		$V_{DD} = 15V$, $V_{O} = 1.5V$ or $13.5V$	11		11			11		V
I _{OL}	LOW Level	$V_{IL} = 0V$, $V_{IH} = V_{DD}$								
	Output Current	$V_{DD} = 5.0V, V_{O} = 0.4V$	0.52		0.44	0.88		0.36		mA
	(Note 3)	$V_{DD} = 10V, V_{O} = 0.5V$	1.3		1.1	2.2		0.9		mA
		$V_{DD} = 15V, V_{O} = 1.5V$	3.6		3.0	6.0		2.4		mA
I _{OH}	HIGH Level	$V_{IL} = 0V$, $V_{IH} = V_{DD}$								
	Output Current	$V_{DD} = 5.0V, V_{O} = 4.6V$	-0.52		-0.44	-0.32		-0.36		mA
	(Note 3)	$V_{DD} = 10V, V_{O} = 9.5V$	-1.3		-1.1	-0.8		-0.9		mA
		$V_{DD} = 15V, V_{O} = 13.5V$	-3.6		-3.0	-2.4		-2.4		mA
I _{IN}	Input Current	$V_{DD} = 15V, V_{IN} = 0V$	-0.3			-0.3			-1.0	μА
		$V_{DD} = 15V, V_{IN} = 15V$	0.3			0.3			1.0	μΑ

Note 3: I_{OH} and I_{OL} are tested one output at a time.

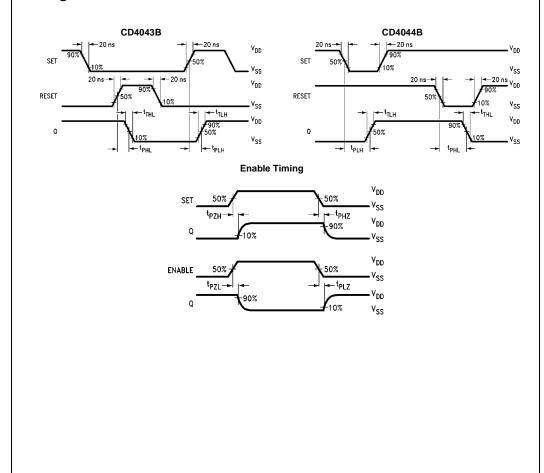
AC Electrical Characteristics (Note 4)

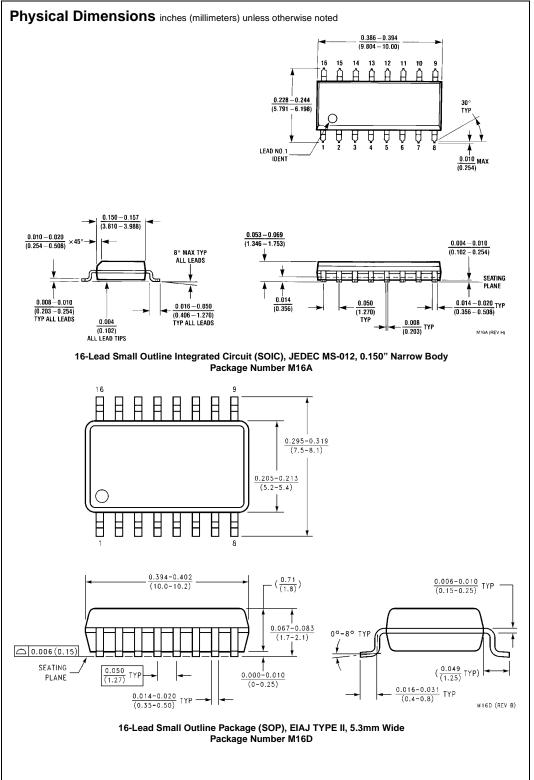
 ${\rm T_A} = 25^{\circ}{\rm C},~{\rm C_L} = 50~{\rm pF},~{\rm R_L} = 200{\rm k},~{\rm input}~{\rm t_f} = {\rm t_f} = 20~{\rm ns},~{\rm unless~otherwise~noted}$

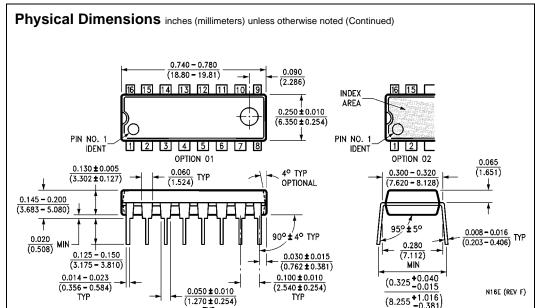
Symbol	Parameter	Conditions	Min	Тур	Max	Units
t _{PLH} , t _{PHL}	Propagation Delay S or R to Q	$V_{DD} = 5.0V$		175	350	ns
		$V_{DD} = 10V$		75	175	ns
		V _{DD} = 15V		60	120	ns
t _{PZH} , t _{PHZ}	Propagation Delay Enable to Q (HIGH)	$V_{DD} = 5.0V$		115	230	ns
		$V_{DD} = 10V$		55	110	ns
		V _{DD} = 15V		40	80	ns
t _{PZL} , t _{PLZ}	Propagation Delay Enable to Q (LOW)	$V_{DD} = 5.0V$		100	200	ns
		$V_{DD} = 10V$		50	100	ns
		V _{DD} = 15V		40	80	ns
t _{THL} , t _{TLH}	Transition Time	V _{DD} = 5.0V		100	200	ns
		$V_{DD} = 10V$		50	100	ns
		V _{DD} = 15V		40	80	ns
t _{WO}	Minimum SET or RESET Pulse Width	$V_{DD} = 5.0V$		80	160	ns
		$V_{DD} = 10V$		40	80	ns
		V _{DD} = 15V		20	40	ns
C _{IN}	Input Capacitance			5.0	7.5	pF

Note 4: AC Parameters are guaranteed by DC correlated testing.

Timing Waveforms







16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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